Notice of References Cited Application/Control No. 10/584,329 Examiner SEAN M. MICHALSKI Applicant(s)/Patent Under Reexamination TOYAMA, HIDEO Art Unit Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,151,785 A	11-2000	Morris, Lionel	30/206
*	В	US-6,725,546 B1	04-2004	Dallas et al.	30/193
*	С	US-2005/0217118 A1	10-2005	Mah, Pat Y.	030/261
*	D	US-7,111,402 B1	09-2006	Pearman, Robert E.	30/158
*	Е	US-2006/0200996 A1	09-2006	Pearman, Robert E.	030/158
*	F	US-2007/0144014 A1	06-2007	Toyama, Hideo	030/254
*	G	US-5,815,866	10-1998	Janky, Greg	7/114
	Н	US-			
	ı	US-			
	J	US-			
	K	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
*	Ν	DE 3830934 A1	03-1990	Germany	POGGETTI, PIETRO	B26B 13/20
	0					
	Ρ					
	σ					
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	C					
	V					
	w					
	х					

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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